

7th IEEE Electron Devices Technology and Manufacturing (EDTM) Conference 2023

March 7 – 10, 2023 / COEX Seoul, Korea

| 14G. Neural Network Based Modeling and Simulation | | |
|---|---|-------------|
| Session Date: | March 8(Wed.), 2023 | |
| Session Time: | 13:30-14:55 | |
| Session Room: | Room G (#318) | |
| Session Chair | Prof. Min-Hwi Kim (Chung-Ang University) | |
| | | |
| [14G-1] [Invited] | | 13:30-13:55 |
| Neural Compact Modeling: Motivation, State of the Art, Future Perspectives | | |
| Hyunbo Cho | | |
| Alsemy Inc. | | |
| [14G-2] | | 13:55-14:10 |
| Coupled Multiple Physics-Informed Deep Operator Networks for Boltzmann Transport | | |
| Simulations of Nanowire Field Effect Transistors | | |
| Bokyeom Kim and Mincheol Shin | | |
| Korea Advanced Institute of Science and Technology | | |
| [14G-3] | | 14:10-14:25 |
| Accelerated Simulation and Performance Optimization of 3D Multigate Logic Transistors by | | |
| Using Neural Networks | | |
| Seung-Cheol Han, In Ki Kim and Sung-Min Hong | | |
| Gwangju Institute of Science and Technology | | |
| [14G-4] | | 14:25-14:40 |
| Variability Aware FET Model with Physics Knowledge Based Machine Learning | | |
| Kumar Sheelvardha | n, Surila Guglani, M. Ehteshamuddin, Sourajeet Roy and Avirup | Dasgupta |
| Indian Institute of Technology Roorkee | | |
| [14G-5] | | 14:40-14:55 |
| Graphical Approach of Equipment Health Monitoring Using Network Analysis | | |
| Wanwook Ki, Minjae Choi, Yongjun Lee, Kiseop Yoon, Hanchan Hwang, Jisoo Park, Taewook Kang, | | |
| Jaeyong Park and Younghoon Kim | | |
| Samsung Electronic | cs Co., Ltd | |